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# IMPROVEMENT OF DIELECTRIC STRENGTHS FOR CROSS-LINKED POLYETHYLENE (XLPE) MEDIUM VOLTAGE CABLES

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#### Abstract

The electricity distribution companies are interested of the types of polymeric materials used in medium voltage cables which is considered the basis of power grid. In this study, it tried to enhance the electrical properties of cross-linked polyethylene (XLPE) after adding inorganic filler: such as Silica (SiO2) filler with 10%, 20%, 30% and 40% concentration percentages. The dielectric strength of the samples was tested under different thermal conditions (0, 25 and 100 C0) to simulate different types of environments. Thermal aging is simulated for one week in several temperatures (70, 100 and 120 C0) to investigate the effect of variety higher temperature stresses on the electric properties of XLPE in thermal drying oven, after adding Silica filler. Curve fitting is used to choosing the most suitable equation between dielectric strength rates under each thermal condition and variant percentages of Silica filler. It noted that the highest value of dielectric strength for XLPE can be obtained with 30% percentage of SiO2 filler [max. at 70 Co(30.07kV/mm)]. Polynomial regression by MATLAB code has been adopted to find the proper percentages of SiO2 filler and the highest value of dielectric strength. This regression algorithm is a form of linear regression where higher order powers (2<sup>nd</sup>, 3<sup>rd</sup> ...) of an independent variable are included, and it describes a relationship between an explanatory variable and a response variable.

Keywords: Dielectric Strength; XLPE; Silica (SiO2); Degradation; Aging; Polynomial Regression.

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# 1. Introduction

Underground cables are an important part of any power distribution system. These cables are laid in ducts or may be buried in the ground. Unlike in overhead lines, air does not form part of the insulation and the conductor must be completely insulated. This means that the selection of cable must be based on the losses, cost and environmental factors surrounding [1]. One important factor in the safety and reliability of cables is the integrity of their polymeric insulation and jacket materials [2]. During production of insulation materials, degradation may be occurred due to the heat which material are exposed. The final manufacture affected by some factors such as plastic type, manufacturing temperature, and the substances used. The output products should be kept at high quality, by eliminate degradation of insulation as much as possible.

XLPE is made from low density polyethylene (LDPE). It is mixed with dicumyl peroxide 4methoxy phenol (3 wt%) as cross-linked agent in absence of filler to prepare XLPE according to (ASTMF876-10el). To prepare XLPE composites of different ratios (10, 20,30 and 40 wt%) of silica (SiO<sub>2</sub>). All samples are tested according to (IEC 60156) for electrical tests.

Polymeric materials used for electrical insulation not only have to exhibit acceptable physical properties but good electrical properties. 01 concerning the so-called charge trapping event in dielectric and insulating materials [3–4].

Power cable aging is affected by different factors some internal due to flowing electricity and external related to the environment. Those factors include intensity of the current, mechanical wiring systems, water and thermal aging. The mechanism of cable aging is mostly carried out in the form of insulating material temperature. The temperature rise accelerates the chemical reaction of the insulator and accelerates the process of insulator deterioration caused by other aging factors [5-6].

The surrounding environment, the operating conditions and the load connected to cable are factors that easily influence the cable. Therefore, the core, insulation layer and its surface will heat. The closer it is to the core, the higher the temperature is. In long-term over-load operation, when the current flowing through the cable exceeds its rated capacity, the temperature of the core will rise abnormally. The aging of the cable insulation material will accelerate under over-heat temperature; insulation breakdown may occur; hence the core temperature should be used as the aging temperature of cable. The cable core temperature is estimated according to the cable actual operation and equivalent environmental temperature [7].

The endurance test was set at high ac field by testing transformer (HV transformer 9105-terco) and at high temperature by aging oven (heraeus-6450hanau), to maximize the stress and minimize the life of the material. All samples were conditioned before the test to remove any impurities or humidity. The least squares technique (regression analysis) used to analysis results by choosing the polynomial that makes the sum of squares of these errors as small as possible.

Regression analysis is a statistical tool for the investigation of relationships between variables. Regression is a statistical technique to determine the linear relationship between two or more variables. Regression is primarily used for prediction and causal inference. In its simplest (bivariate) form, regression shows the relationship between one independent variable (X) and a dependent variable (Y). Regression thus shows us how variation in one variable co-occurs with variation in another, an objective of the software engineering community is that to develop a useful models that are accurately estimates the software effort [8]. Indeed, assembling a single global model can be very difficult. In non-linear regressions, the space is divided into smaller regions, where the interactions are more manageable [9]. From this analysis it can recognize the suitable curve or adequate line which introduce the favorite fit of points of the measured data. This curve or line used to clarify the expected direction of data whether it is linear, parabolic, or other form. There are various methods specialist execute regression analysis.

The present work has been devoted to study the effects and the consequences after adding an inorganic filler (silica filler) in XLPE on the electrical performance of cross-linked polyethylene used in medium voltage cables. These effects cab be noted by measuring the dielectric strength of XLPE under several temperatures range tests regard to different weight percentages of filler.

# 2. Materials and Methods

The preparation of XLPE depends on different parameters such as the ratio of XLPE, types and concentrations of filler that effect on properties of the base material and final product. Samples have been prepared in the laboratory of the polymers and pigments department National Research Center (NRC). Polymer composite was prepared by mixing different ratios of Silica filler (0, 10, 20, 30 and 40 wt. %). The samples preparation was operated at the room temperature (25°C), until curing occurred. The experimental setup of dielectric strength in HV laboratory shown in fig (1).



Figure 1: Experimental setup of dielectric strength in the HV laboratory

The dielectric strength test was performed according to the ASTMD149 and IEC6024 standard . The electrodes configuration is two stainless steel cylinders with diameter of 25 mm at room temperature as shown in Fig (2). The voltage was increased at a rate of 1 kV/s until breakdown occurs, which is a measure of samples dielectric strengths. For each type of the specimens, 10 pieces of specimens are prepared and tested. The median value of the 10 test results is taken to evaluate the performance of the samples and the odd values are eliminated.



Figure 2: Two stainless steel electrodes consists of supporting arrangements and hand operated gear.

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Figure 3: HV 9103 control desk includes measuring instruments and trigger device.

Dielectric strength is calculated by dividing the breakdown voltage by the thickness of the sample. The data is expressed in (kV/mm) and measured through a circular sample of 1 mm thickness and 50 mm diameter.

A higher dielectric strength represents a better quality of insulator, which it tries to get the highest value through this research. The Control desk includes measuring instruments used in our experiments is shown in fig (3).

# 3. Results and Discussions

# **3.1. Dielectric Strength Measurements Under Various Temperatures**

Dielectric strength of an insulating material, is the highest value of electric field intensity which the insulator can endure internally without failure of its insulating properties until breaking down of insulator occur. The failure happens when too much current flow through material and fractional devastation occur. It is scientifically agreed that the greater the dielectric strength the greater the efficiency of the insulator.

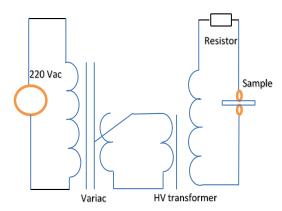


Figure 4: Schematic diagram for dielectric strength testing circuit.

The dielectric strength of XLPE have been studied under several environment conditions, i.e. :  $0^{\circ}$ C, 25°C (room temperature) and 100 °C with different percentages of filler which is (SiO<sub>2</sub> filler), Fig. (4) shows the circuit used for dielectric strength test.

#### Addition of SiO<sub>2</sub> filler

Average dielectric strength (kV/mm) for XLPE with different SiO<sub>2</sub> filler percentages at variant thermal conditions, i.e. 0°C ,25°C (room temperature) and 100 °C shown in table (1) and drawn in figure (5). It can be noted that the dielectric strength of XLPE was improved by adding SiO<sub>2</sub> filler. It can be concluded from the results in table (1) that:

When the Sio<sub>2</sub> filler was increased from 10% to 30 % the value of dielectric strength increased from 22.9% to 38.8% compared to XLPE sample without adding any filler percentage.

Then after adding more filler (from 30% to 40 %), the value of dielectric strength of XLPE decreased from 38.8% to 26.8% compared to XLPE sample without adding any filler percentage.

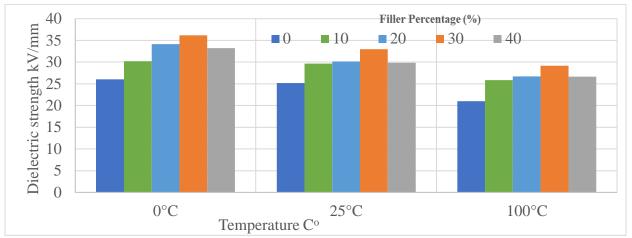


Figure 5: Relation between dielectric strength (kV/mm) and filler percentages at variant temperature.

SiO <sub>2</sub> filler	The average of dielectric strength (kV/mm) at variant		
percentages (%)	temperature		
	0°C	25°C	100°C
0	26.04	25.16	21.02
10	30.24	29.64	25.83
20	34.15	30.18	26.74
30	36.18	32.98	29.17
40	33.21	29.87	26.66

# 3.2. Thermal Aging and Dielectric Strength Measurements

The accelerated thermal aging oven is the most commonly used method for the accelerated thermal aging format [10-11]. It mainly utilizes the rapid heating in the oven to simulate the aging state of the cable insulation material in real usage and compares and analysis the

characteristic value of life which is highly related with the lifetime [7]. Due to temperature limitation and interval, three aging temperature were chosen, that is 70 °C, 100 °C and 120°C, where the average dielectric strength (kV/mm) for XLPE with different SiO2 filler percentages was measured after the samples were exposed to these aging temperatures for one week, results are shown in table (2) and drawn in fig (6).

SiO <sub>2</sub> filler percentages	Average of dielectric strength (kV/mm) at variant		
(%)	temperatures		
	0°C	25°C	100°C
0	22.81	20.42	19.13
10	26.22	24.85	22.11
20	27.94	23.87	23.16
30	30.07	27.55	25.17
40	28.15	22.01	22.91

Table 2: Average dielectric strengths (kV/mm) of samples at variant temperatures after one week

After each aging process (168 hrs), samples were placed in the constant room temperature at 25 C°, it observed from results that when  $SiO_2$  filler percentage increased from 10% to 30 %, the value of dielectric strength increased from 22.9% to 38.8% compared to XLPE sample without adding any filler percentage.

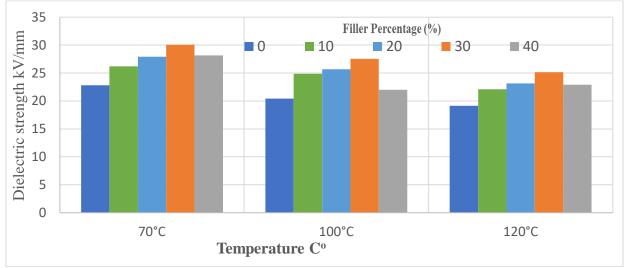


Figure 6: Relation between dielectric strength (kV/mm) and filler percentages after one week aging.

Applying Curve fitting (polynomial regression analysis) using MATLAB program, the highest curve fitting for the obtained results from the test can be represented by a 3rd degree polynomial equation to minimize the error as possible. It can talk in details about each case of exposing samples to every level of aging temperature for one week as follow:

# At 70 °C Temperature Level

The Effect of filler addition on dielectric strength and the observed error between actual and predicted dielectric strength (kV/mm) after one week aging 70 °C are shown in table (3) and drawn in fig (7). The equation of curve fitting results of blends at that case, can be determined as follows:

$$\boldsymbol{D}_{70} = -0.0001967\boldsymbol{P}^3 + 0.0044786\boldsymbol{P}^2 + 0.269\boldsymbol{P} + 22.9 \tag{1}$$

Where D70 parameter is the dielectric strength value (KV/mm) at 70 °C condition, P is the percentage of concentration of Silica filler in the samples.

$$Error_{70} = Actual \ DS_{70} - Predicted \ DS_{70}$$
(2)

Where  $Error_{70}$  is the observed error between actual and predicted dielectric strength at 70 °C (DS70), The method of least squares chooses the polynomial that makes the sum of the squares of these errors as small as possible.



Figure 7: Effect of filler addition on dielectric strength after one week aging 70 °C.

Actual <sup>70</sup> dielectric strength (KV/mm)	Predicted70 dielectric strength (KV/mm)	Error70 value
22.81	22.9	-0.09
26.28	25.84	0.38
27.94	28.49	-0.55
30.07	29.69	0.38
28.15	28.23	-0.08

Table 3: Observed error between actual and predicted dielectric strength at 70 °C

(4)

# At 100 °C Temperature Level

The Effect of filler addition on dielectric strength and the observed error  $Error_{100}$  between actual and predicted dielectric strength (DS<sub>100</sub>) at 100 °C after one week aging are shown in table (4) and drawn in fig (8). The equation of curve fitting results of blends at that case, can be determined as follows:

$$\boldsymbol{D}_{100} = -0.0003175\boldsymbol{P}^3 + 0.005564\boldsymbol{P}^2 + 0.3252\boldsymbol{P} + 20.61 \tag{3}$$

 $Error_{100} = Actual DS_{100} - Predicted DS_{100}$ 

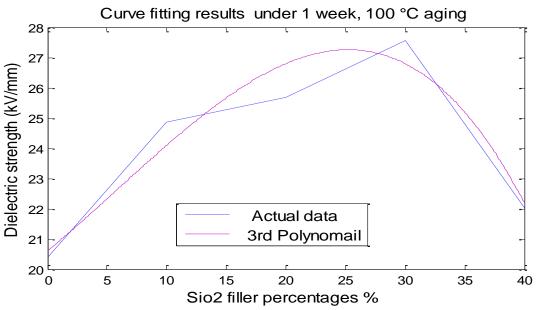


Figure 8: Effect of filler addition on dielectric strength after one-week aging at 100°C.

Actual <sub>100</sub> dielectric strength	Predicted100 dielectric strength	Error <sub>100</sub>
(KV/mm)	(KV/mm)	value
20.42	20.61	0.18
24.85	24.1	0.75
25.67	26.79	-1.12
27.55	26.8	0.75
22.01	22.19	-0.18

Table 4: Observed error between actual and predicted dielectric strength at 100 °C

# At 120 °C Temperature Level

The Effect of filler addition on dielectric strength and the observed error between actual and predicted dielectric strength ( $DS_{100}$ ) at 120 °C after one week aging are shown in table (5) and drawn in figure (9). The equation of curve fitting results of blends at that case, can be determined as follows:

$$\boldsymbol{D}_{120} = -0.000195\boldsymbol{P}^3 + 0.0049\boldsymbol{P}^2 + 0.2105\boldsymbol{P} + 19.25 \tag{5}$$

 $Error_{120} = Actual DS_{120} - Predicted DS_{120}$ 

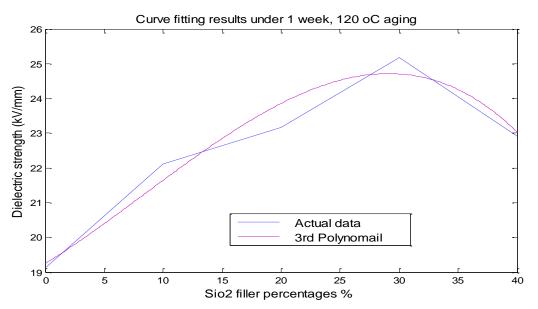


Figure 9: Effect of filler addition on dielectric strength after one-week aging at 120 °C.

Actual <sub>120</sub> dielectric strength (KV/mm)	Predicted <sub>120</sub> dielectric strength (KV/mm)	Error <sub>120</sub> value
19.13	19.25	-0.12
22.11	21.65	0.46
23.16	23.85	-0.69
25.17	24.71	0.46
22.91	23.03	-0.12

Table 5: Observed error between actual and predicted dielectric strength at 120 °C

It was observed from the previous three cases, that dielectric strengths gradually increased with increasing the  $SiO_2$  filler percentage until definite value, then it was decreased. This is due to the saturation that happened in the lattice of XLPE and the more addition of  $SiO_2$  filler to XLPE made the composites brittle so dielectric strength decreased, and due to increasing flow of leakage current that increases the opportunity of break down to occur.

# 4. Conclusions and Recommendations

From this study, It can be noted that suitable addition of SiO2 filler had resulted some improvement in the electrical properties of XLPE, where the dielectric strength of XLPE was improved. Without thermal aging, the highest value of dielectric strength for XLPE can be obtained with 30% percentage of SiO<sub>2</sub> filler [max. at 0 C°(36.18kV/mm)]. After the exposure of samples for one week (168 hrs) thermal stress, the highest value of dielectric strength for XLPE can be obtained with 30% percentage of SiO<sub>2</sub> filler [max. at 70 C°(30.07kV/mm)]. Suitable percentages of SiO<sub>2</sub> filler must be added to XLPE, where more addition of filler lead to decreasing of XLPE dielectric strength, the decreasing of XLPE dielectric strength may be understood that exposing the samples to different high temperatures for long period lead to changing the physical structure of samples and it became

(6)

more rigid than before where color start to change and composite bonds starting to broke. Finally, it recommends that  $SiO_2$  filler is suitable for application of XLPE underground cables used in electricity companies for medium voltage cable (11 kV up to 66 kV).

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